PHOTONIC DETECTORS INC.

Silicon Photodiode, U.V. Enhanced Photovoltaic Type PDU-V113



PACKAGE DIMENSIONS INCH (mm) RED DOT INDICATES ANODE 0.140 [3.56] MAX 0.070 [1.78] 1.50 [38.1] MIN 0.224 [5.69] WIRF BONDS ANODE PHOTODIODE ç 120° VIEWING Ø0.265 [6.73] 0.200 [5.08] ANGLE Ģ Ø0.020 [0.51] OPTICAL EPOXY CATHODE CERAMIC 0.125 [3.18] SQUARE 0.113 [2.87] SQ ACTIVE AREA CERAMIC PACKAGE ŧ ACTIVE AREA = 7.95 mm²

FEATURES

- Low noise
- U.V. enhanced
- High shunt resistance
- High response

The **PDU-V113** is a silicon, PIN planar diffused, U.V. enhanced photodiode. Ideal for low noise photovoltaic applications. Packaged on a two lead ceramic substrate with a clear U.V. epoxy glob top.

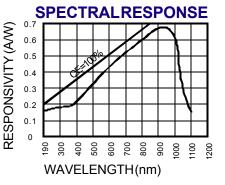
APPLICATIONS

- U.V. exposure meter
- Water purification
- Fluorescence
- U.V. A & B meters

ABSOLUTE MAXIMUM RATING (TA=25°C unless otherwise noted)

DESCRIPTION

SYMBOL	PARAMETER	MIN	MAX	UNITS
Vbr	Reverse Voltage		75	V
T _{STG}	Storage Temperature	-40	+100	°C
To	Operating Temperature Range	-40	+90	°C
Ts	Soldering Temperature*		+240	°C
Ι _L	Light Current		500	mA



*1/16 inch from case for 3 secs max

ELECTRO-OPTICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	MIN	TYP	MAX	UNITS
lsc	Short Circuit Current	H = 100 fc, 2850 K	60	80		μ A
ΙD	Dark Current	H = 0, V _R = 10 V		300	500	pА
Rsh	Shunt Resistance	H = 0, V _R = 10 mV	100	200		MΩ
TC RSH	RsH Temp. Coefficient	H = 0, V _R = 10 mV		-8		% / °C
CJ	Junction Capacitance	H = 0, V _R = 0 V**		800		pF
λrange	Spectral Application Range	Spot Scan	250		1100	nm
λρ	Spectral Response - Peak	Spot Scan		850		nm
Vbr	Breakdown Voltage	I = 10 μA	30	50		V
NEP	Noise Equivalent Power	V _R = 10 mV @ Peak		6x10 ⁻¹⁴		W/ √ Hz
tr	Response Time	$RL = 1 K\Omega V_R = 0 V$		750		nS

Information in this technical data sheet is believed to be correct and reliable. However, no responsibility is assumed for possible inaccuracies or omission. Specifications are subject to change without notice.**f=1MHz [FORM NO. 100-PDU-V113 REV A]